

an Open Access Journal by MDPI

Impact Factor 1.5 CiteScore 2.6

Metrology



mdpi.com/ journal/ metrology



Message from the Editor-in-Chief

Metrology draws together researchers from diverse areas of metrology or measurement technology in a wide variety of applications. I encourage you to submit your manuscripts for consideration or publication in the area of measurement engineering, according to the scope of the journal. Metrology is supported by our authors and their institutes through low article processing charges (APC) for accepted papers. We hope you will support the journal by becoming one of our authors.

Editor-in-Chief

Prof. Dr. Han Haitjema

Aims

Metrology (ISSN 2673-8244) is an international, peer-reviewed, open access journal that provides an advanced forum for articles covering theory, design, and application in measurement science or measurement technology. Metrology publishes full research papers, communications, and review articles as well as Special Issues on particular subjects.

The aim of *Metrology* is to encourage scientists to publish their experimental and theoretical results in as much detail as possible. Therefore, the journal has no restrictions regarding the length of papers. Full experimental details should be provided so that the results can be reproduced.

Scope

- Traceability to SI units of complex measurement systems;
- Measurement theory in a broad context;
- Measurement uncertainty and uncertainty evaluation;
- Considerations on the fundamentals of measurement:
- Error separation methods;
- Novel methods inspired by the redefinition of the SI;
- Artificial intelligence, especially its effect on traceability;
- Machine learning for metrology;
- Precision measurement;
- Digital twins;
- Metrology for sustainable manufacturing;
- Precision manufacturing;
- Measurement techniques and devices;
- Interferometry:
- XCT measurements;
- Three-dimensional metrology;
- Frequency metrology;
- Surface metrology;
- Biomedical measurement;
- Virtual measurement;
- Power measurement.
- Sensor calibration.

Author Benefits

Open Access

Unlimited and free access for readers

No Copyright Constraints

Retain copyright of your work and free use of your article

Thorough Peer-Review

Discounts on Article Processing Charges (APC)

If you belong to an institute that participates with the MDPI Institutional Open Access Program

No Space Constraints, No Extra Space or Color Charges

No restriction on the maximum length of the papers, number of figures, or use of colors

Journal Rank

CiteScore - Q2 (Engineering (miscellaneous))

Coverage by Leading Indexing Services

ESCI (Web of Science), Scopus and other databases

Rapid Publication

A first decision is provided to authors approximately 37 days after submission; acceptance to publication is undertaken in 5.8 days (median values for papers published in this journal in the first half of 2025)

MDPI is a member of





















ORCID



Editorial Office minerals@mdpi.com

MDPI Grosspeteranlage 5 4052 Basel, Switzerland Tel: +41 61 683 77 34 mdpi.com

July 2025

